


<b>Search Notes</b>  	<b>Application/Control No.</b>  10642934	<b>Applicant(s)/Patent Under Reexamination</b>  NGUYEN ET AL.
	<b>Examiner</b>  Lee, Benjamin W	<b>Art Unit</b>  3714

SEARCHED			
Class	Subclass	Date	Examiner
463	22, 25, 266, 29, 42, 43	2/16/2007	BWL

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Name Search	2/12/2007	BWL
Assignee Name Search	2/12/2007	BWL
Consulted with Kim Nguyen, Cls. 463	2/14/2007	BWL
PLUS Search	1/19/2007	BWL
East Text Search (see attached "Search History")	2/16/2007	BWL
Backwards/Forwards Search	2/16/2007	BWL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner